

Day : Wednesday

Date: 11/29/2006

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PALM INTRANET**Inventor Name Search Result**

Your Search was:

Last Name = SMILANSKY

First Name = ZEEV

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>07650468</u>	<u>5339176</u>	150	02/04/1991	APPARATUS AND METHOD FOR COLOR CALIBRATION	SMILANSKY, ZEEV
<u>08122507</u>	<u>5495535</u>	150	09/24/1993	METHOD OF INSPECTING ARTICLES	SMILANSKY, ZEEV
<u>08172592</u>	Not Issued	161	12/21/1993	APPARATUS AND METHOD FOR COLOR CALIBRATION	SMILANSKY, ZEEV
<u>08405938</u>	<u>5774573</u>	150	03/17/1995	AUTOMATIC VISUAL INSPECTION SYSTEM	SMILANSKY, ZEEV
<u>09110870</u>	<u>6366690</u>	150	07/07/1998	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
<u>09270924</u>	<u>6323856</u>	250	03/16/1999	METHOD FOR PROCESSING VARIABLE SPEED SCENES FOR COMPUTER GAMES	SMILANSKY, ZEEV
<u>09377347</u>	Not Issued	161	08/19/1999	METHOD AND APPARATUS FOR INSPECTION OF PRINTED CIRCUIT BOARDS	SMILANSKY, ZEEV
<u>09607343</u>	<u>RE38559</u>	150	06/30/2000	AUTOMATIC VISUAL INSPECTION SYSTEM	SMILANSKY, ZEEV
<u>09633756</u>	Not Issued	93	08/07/2000	APPARATUS AND METHODS FOR THE INSPECTION OF OBJECTS	SMILANSKY, ZEEV
<u>09782626</u>	Not Issued	71	02/13/2001	Multiple optical input inspection system	SMILANSKY, ZEEV
<u>10003347</u>	<u>7016526</u>	150	12/06/2001	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
<u>10056483</u>	Not Issued	161	01/28/2002	Method for comparing signal arrays in digital images	SMILANSKY, ZEEV
<u>10148162</u>	Not	164	10/03/2002	METHOD FOR	SMILANSKY, ZEEV

	Issued			REGISTERING SEPARATION PATTERNS	
<u>10281125</u>	Not Issued	161	10/28/2002	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
<u>10281229</u>	<u>6810139</u>	150	10/28/2002	PIXEL BASED MACHINE FOR PATTERNED WAFERS	SMILANSKY, ZEEV
<u>10399018</u>	Not Issued	41	07/15/2003	Method for determining mass altering moiety in peptides	SMILANSKY, ZEEV
<u>10537071</u>	Not Issued	30	01/09/2006	Protein synthesis monitoring (psm)	SMILANSKY, ZEEV
<u>10658819</u>	Not Issued	30	09/08/2003	Miniature autonomous agents for scene interpretation	SMILANSKY, ZEEV
<u>10706440</u>	Not Issued	93	11/12/2003	APPARATUS AND METHODS FOR THE INSPECTION OF OBJECTS	SMILANSKY, ZEEV
<u>10706489</u>	Not Issued	41	11/12/2003	Apparatus and methods for the inspection of objects	SMILANSKY, ZEEV
<u>11042084</u>	Not Issued	71	01/26/2005	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
<u>11042509</u>	Not Issued	30	01/26/2005	Pixel based machine for patterned wafers	SMILANSKY, ZEEV
<u>60429532</u>	Not Issued	159	11/29/2002	Protein synthesis monitoring (PSM)	SMILANSKY, ZEEV
<u>60574210</u>	Not Issued	159	05/26/2004	Measuring RNA by protein synthesis monitoring (PSM)	SMILANSKY, ZEEV
<u>60737379</u>	Not Issued	159	11/17/2005	System and methods for measuring general translation activity in viable cells	SMILANSKY, ZEEV
<u>60847380</u>	Not Issued	20	09/27/2006	System and methods for measuring general translation activity in viable cells	SMILANSKY, ZEEV

Inventor Search Completed: No Records to Display.

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